## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10764087	DEMIR ET AL.	
Examiner	Art Unit	
Nguyen, Huy D	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
455	502, 550.1, 434, 436, 437, 440, 422.1, 435.1	3/14/2007	HN		
Updated search 455	502, 550.1, 434, 436, 437, 440, 422.1, 435.1	7/18/2007	HN		

SEARCH NOTES				
Search Notes	Date	Examiner		
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	3/14/2007	HN		
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	7/18/2007	HN		
See interference search printout.	7/18/2007	HN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
455	502,550.1,434	7/18/2007	HN		

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